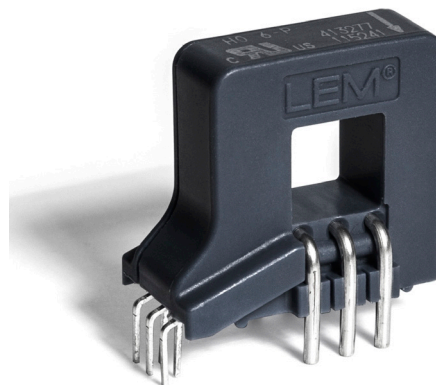


Ref: HO 6-P, HO 10-P, HO 25-P

For the electronic measurement of current: DC, AC, pulsed..., with galvanic separation between the primary and the secondary circuit.



## Features

- Hall effect measuring principle
- Galvanic separation between primary and secondary circuit
- Insulated test voltage 4300 V
- Low power consumption
- Single power supply +5 V
- Fixed offset & sensitivity
- Overcurrent detection  $2.63 \times I_{PN}$  (peak value)
- Memory check.

## Advantages

- Small size and space saving
- Only one design for wide primary current range
- High immunity to external interference
- 8 mm creepage/clearance
- High insulation capability
- Fast delay time.

## Applications

- AC variable speed drives
- Static converters for DC motor drives
- Battery supplied applications
- Uninterruptible Power Supplies (UPS)
- Switched Mode Power Supplies (SMPS)
- Power supplies for welding applications
- The solar inverter on DC side of the inverter (MPPT)
- Combiner box.

## Standards

- EN 50178: 1997
- IEC 61010-1: 2010
- IEC 61326-1: 2012
- UL 508: 2018.

## Application Domain

- Industrial.

## Safety



Caution

If the device is used in a way that is not specified by the manufacturer, the protection provided by the device may be compromised. Always inspect the electronics unit and connecting cable before using this product and do not use it if damaged. Mounting assembly shall guarantee the maximum primary conductor temperature, fulfill clearance and creepage distance, minimize electric and magnetic coupling, and unless otherwise specified can be mounted in any orientation.



Caution, risk of electrical shock

This transducer must be used in limited-energy secondary circuits SELV according to IEC 61010-1, in electric/electronic equipment with respect to applicable standards and safety requirements in accordance with the manufacturer's operating specifications.

Use caution during installation and use of this product; certain parts of the module can carry hazardous voltages and high currents (e.g. power supply, primary conductor).

Ignoring this warning can lead to injury and/or cause serious damage.

De-energize all circuits and hazardous live parts before installing the product.

All installations, maintenance, servicing operations and use must be carried out by trained and qualified personnel practicing applicable safety precautions.

This transducer is a build-in device, whose hazardous live parts must be inaccessible after installation.

This transducer must be mounted in a suitable end-enclosure.

Besides make sure to have a distance of minimum 30 mm between the primary terminals of the transducer and other neighboring components.

Main supply must be able to be disconnected.

Never connect or disconnect the external power supply while the primary circuit is connected to live parts.

Always wear protective clothing and gloves if hazardous live parts are present in the installation where the measurement is carried out.

This transducer is a built-in device, not intended to be cleaned with any product. Nevertheless if the user must implement cleaning or washing process, validation of the cleaning program has to be done by himself.



ESD susceptibility

The product is susceptible to be damaged from an ESD event and the personnel should be grounded when handling it.

Do not dispose of this product as unsorted municipal waste. Contact a qualified recycler for disposal.

Although LEM applies utmost care to facilitate compliance of end products with applicable regulations during LEM product design, use of this part may need additional measures on the application side for compliance with regulations regarding EMC and protection against electric shock. Therefore LEM cannot be held liable for any potential hazards, damages, injuries or loss of life resulting from the use of this product.



Underwriters Laboratory Inc. recognized component

## Absolute maximum ratings

Parameter	Symbol	Unit	Value
Supply voltage (not operating)	$U_C$	V	6.5
Primary conductor temperature	$T_B$	°C	125
Electrostatic discharge voltage (HBM - Human Body Model)	$U_{ESD\ HBM}$	kV	2

Stresses above these ratings may cause permanent damage. Exposure to absolute maximum ratings for extended periods may degrade reliability.

## UL 508: Ratings and assumptions of certification

File # E189713 Volume: 2 Section: 5

### Standards

- CSA C22.2 NO. 14-10 INDUSTRIAL CONTROL EQUIPMENT - Edition 11
- UL 508 STANDARD FOR INDUSTRIAL CONTROL EQUIPMENT - Edition 17

### Ratings

Parameter	Symbol	Unit	Value
Primary involved potential		V AC/DC	600
Maximum surrounding air temperature	$T_A$	°C	105
Primary current	$I_p$	A	According to series primary currents
Secondary supply voltage	$U_C$	V DC	5
Output voltage	$U_{out}$	V	0 ... 5

## Conditions of acceptability

When installed in the end-use equipment, consideration shall be given to the following:

- 1 - These devices have been evaluated for overvoltage category III and for use in pollution degree 2 environment.
- 2 - A suitable enclosure shall be provided in the end-use application.
- 3 - The terminals have not been evaluated for field wiring.
- 4 - These devices have been evaluated for use in 105 °C maximum surrounding air temperature.
- 5 - The secondary (Sensing) circuit is intended to be supplied by an Isolated Secondary Circuit - Limited voltage circuit defined by UL 508 paragraph 32.5. The maximum open circuit voltage potential available to the circuit and overcurrent protection shall be evaluated in the end use application.
- 6 - These devices are intended to be mounted on a printed wiring board of end-use equipment. The suitability of the connections (including spacings) shall be determined in the end-use application.
- 7 - Any surface of polymeric housing have not been evaluated as insulating barrier.
- 8 - Low voltage circuits are intended to be powered by a circuit derived from an isolating source (such as a transformer, optical isolator, limiting impedance or electro-mechanical relay) and having no direct connection back to the primary circuit (other than through the grounding means).

## Marking

Only those products bearing the UL or UR Mark should be considered to be Listed or Recognized and covered under UL's Follow-Up Service. Always look for the Mark on the product.

## Insulation coordination

Parameter	Symbol	Unit	Value	Comment
RMS voltage for AC insulation test, 50 Hz, 1 min <sup>1)</sup>	$U_d$	kV	4.3	
Impulse withstand voltage 1.2/50 $\mu$ s	$U_{Ni}$	kV	8	
Partial discharge extinction test voltage ( $q_m < 10$ pC)	$U_t$	V	1650	
Clearance (pri. - sec.)	$d_{Cl}$	mm	8	Shortest distance through air
Creepage distance (pri. - sec.)	$d_{Cp}$	mm	8	Shortest path along device body
Case material	-	-	V0	According to UL 94
Comparative tracking index	$CTI$		600	
Application example		V	600	Reinforced insulation, CAT III, PD 2 non uniform field according to EN 50178
Application example		V	300	Reinforced insulation, CAT III, PD 2 non uniform field according to IEC 61010
Application example		V	1000	Simple insulation, CAT III, PD 2 non uniform field according to IEC 61010

## Environmental and mechanical characteristics

Parameter	Symbol	Unit	Min	Typ	Max	Comment
Ambient operating temperature	$T_A$	°C	-40		105	
Ambient storage temperature	$T_{A\ st}$	°C	-40		105	
Surrounding temperature according to UL 508		°C			105	
Mass	$m$	g		10		

**Note:** <sup>1)</sup> Voltage of Retention pins has to be consider. If it is same as primary electrical potential, insulation is no issue.  
If it is same as secondary electrical potential, insulation of primary bus bar has to be considered.

At  $T_A = 25\text{ °C}$ ,  $U_C = +5\text{ V}$ ,  $N_P = 1\text{ turn}$ ,  $R_L = 10\text{ K}\Omega$  unless otherwise noted (see Min, Max, typ. definition paragraph in [page 8](#)).

Parameter	Symbol	Unit	Min	Typ	Max	Comment
Primary nominal RMS current	$I_{PN}$	A		6		
Primary current, measuring range	$I_{PM}$	A	-20		20	
Supply voltage	$U_C$	V	4.5	5	5.5	
Current consumption	$I_C$	mA		19	25	
Reference voltage	$U_{ref}$	V	2.475	2.5	2.525	Internal reference
External reference voltage	$U_{ref}$	V	0.5		2.65	
Output voltage range @ $I_{PM}$	$U_{out} - U_{ref}$	V	-2		2	
Output voltage @ $I_P = 0\text{ A}$	$U_{out}$	V		$U_{ref} + U_{OE}$		
Electrical offset voltage	$U_{OE}$	mV	-10		10	
Temperature coefficient of $U_{ref}$	$TCU_{ref}$	ppm/K			±160	-20 °C ... 85 °C Internal reference
					±190	-40 °C ... 105 °C Internal reference
Temperature coefficient of $U_{OE}$ referred to primary	$TCU_{OE}$	mV/K			±0.14	-20 °C ... 85 °C
						-40 °C ... 105 °C
Nominal sensitivity	$S_N$	mV/A		100		600 mV/ $I_{PN}$ @ $U_C = 5\text{ V}$
Sensitivity error	$\varepsilon_S$	%			±0.85	Factory adjustment
Temperature coefficient of $S$	$TCS$	ppm/K			±250	
Linearity error 0 ... $I_{PN}$	$\varepsilon_L$	% of $I_{PN}$			±0.5	@ $U_C = 5\text{ V}$
Linearity error 0 ... $I_{PM}$	$\varepsilon_L$	% of $I_{PM}$			±0.8	@ $U_C = 5\text{ V}$
Sensitivity error with respect to $U_C \pm 10\%$	$\varepsilon_S$	%/%			±0.05	Sensitivity error per $U_C$ drift
Magnetic offset voltage @ $I_P = 0$ after $2.5 \times I_{PN}$	$U_{OM}$	mV			±5	
Delay time @ 10 % of the final output value $I_{PN}$ step	$t_{D10}$	µs			2	$di/dt = I_{PN}/\mu s$
Delay time @ 90 % of the final output value $I_{PN}$ step	$t_{D90}$	µs			3.5	$di/dt = I_{PN}/\mu s$
Frequency bandwidth (-3 dB)	$BW$	kHz		250		
Noise voltage spectral density (DC ... 100 kHz)	$u_{no}$	µV/√Hz			32.9	@ $U_C = 5\text{ V}$
RMS noise voltage (DC ... 20 MHz)	$U_{no}$	mVpp		80		
Overcurrent detection		A	$2.6 \times I_{PN}$	$2.9 \times I_{PN}$	$3.2 \times I_{PN}$	peak value
Sum of sensitivity and linearity error @ $I_{PN}$	$\varepsilon_{SL}$	% of $I_{PN}$			±1.35	$= \varepsilon_S + \varepsilon_L$
Sum of sensitivity and linearity error @ $I_{PN}$ @ $T_A = +85\text{ °C}$	$\varepsilon_{SL85}$	% of $I_{PN}$			±4.25	See formula note <sup>1)</sup>
Sum of sensitivity and linearity error @ $I_{PN}$ @ $T_A = +105\text{ °C}$	$\varepsilon_{SL105}$	% of $I_{PN}$			±5.22	See formula note <sup>1)</sup>

**Note:** <sup>1)</sup> Error @  $I_P$  and  $T_A = \pm [\varepsilon_{SL} + (TCS/10000) \cdot (T_A - 25) + TCU_{OE} \cdot 100 \cdot (T_A - 25) / (S_N \cdot I_P)]$ .

At  $T_A = 25\text{ °C}$ ,  $U_C = +5\text{ V}$ ,  $N_P = 1$  turn,  $R_L = 10\text{ K}\Omega$  unless otherwise noted (see Min, Max, typ. definition paragraph in [page 8](#)).

Parameter	Symbol	Unit	Min	Typ	Max	Comment
Primary nominal RMS current	$I_{PN}$	A		10		
Primary current, measuring range	$I_{PM}$	A	-25		25	
Supply voltage	$U_C$	V	4.5	5	5.5	
Current consumption	$I_C$	mA		19	25	
Reference voltage	$U_{ref}$	V	2.475	2.5	2.525	Internal reference
External reference voltage	$U_{ref}$	V	0.5		2.65	
Output voltage range @ $I_{PM}$	$U_{out} - U_{ref}$	V	-2		2	
Output voltage @ $I_P = 0\text{ A}$	$U_{out}$	V		$U_{ref} + U_{OE}$		
Electrical offset voltage	$U_{OE}$	mV	-10		10	
Temperature coefficient of $U_{ref}$	$TCU_{ref}$	ppm/K			±160	-20 °C ... 85 °C Internal reference
					±190	-40 °C ... 105 °C Internal reference
Temperature coefficient of $U_{OE}$	$TCU_{OE}$	mV/K			±0.12	
Nominal sensitivity	$S_N$	mV/A		80		800 mV/ $I_{PN}$ @ $U_C = 5\text{ V}$
Sensitivity error	$\varepsilon_S$	%			±0.85	Factory adjustment
Temperature coefficient of $S$	$TCS$	ppm/K			±250	
Linearity error 0 ... $I_{PN}$	$\varepsilon_L$	% of $I_{PN}$			±0.5	@ $U_C = 5\text{ V}$
Linearity error 0 ... $I_{PM}$	$\varepsilon_L$	% of $I_{PM}$			±0.8	@ $U_C = 5\text{ V}$
Sensitivity error with respect to $U_C \pm 10\%$	$\varepsilon_S$	%/%			±0.05	Sensitivity error per $U_C$ drift
Magnetic offset voltage @ $I_P = 0$ after $2.5 \times I_{PN}$	$U_{OM}$	mV			±6	
Delay time @ 10 % of the final output value $I_{PN}$ step	$t_{D10}$	µs			2	$di/dt = I_{PN}/\mu s$
Delay time @ 90 % of the final output value $I_{PN}$ step	$t_{D90}$	µs			3.5	$di/dt = I_{PN}/\mu s$
Frequency bandwidth (-3 dB)	$BW$	kHz		250		
Noise voltage spectral density (DC ... 100 kHz)	$u_{no}$	µV/√Hz			17.5	
RMS noise voltage (DC ... 20 MHz)	$U_{no}$	mVpp		50		
Overcurrent detection		A	$2.6 \times I_{PN}$	$2.9 \times I_{PN}$	$3.2 \times I_{PN}$	peak value
Sum of sensitivity and linearity error @ $I_{PN}$	$\varepsilon_{SL}$	% of $I_{PN}$			±1.35	$= \varepsilon_S + \varepsilon_L$
Sum of sensitivity and linearity error @ $I_{PN}$ @ $T_A = +85\text{ °C}$	$\varepsilon_{SL85}$	% of $I_{PN}$			±3.75	See formula note <sup>1)</sup>
Sum of sensitivity and linearity error @ $I_{PN}$ @ $T_A = +105\text{ °C}$	$\varepsilon_{SL105}$	% of $I_{PN}$			±4.55	See formula note <sup>1)</sup>

**Note:** <sup>1)</sup> Error @  $I_P$  and  $\varepsilon_{tolTA} = \pm [\varepsilon_{tol} + (TCS/10000) \cdot (T_A - 25) + TCU_{OE} \cdot 100 \cdot (T_A - 25) / (S_N \cdot I_P)]$

## Electrical data HO 25-P

At  $T_A = 25\text{ °C}$ ,  $U_C = +5\text{ V}$ ,  $N_P = 1\text{ turn}$ ,  $R_L = 10\text{ K}\Omega$  unless otherwise noted (see Min, Max, typ. definition paragraph in [page 8](#)).

Parameter	Symbol	Unit	Min	Typ	Max	Comment
Primary nominal RMS current	$I_{PN}$	A		25		
Primary current, measuring range	$I_{PM}$	A	-62.5		62.5	
Supply voltage	$U_C$	V	4.5	5	5.5	
Current consumption	$I_C$	mA		19	25	
Reference voltage	$U_{ref}$	V	2.475	2.5	2.525	Internal reference
External reference voltage	$U_{ref}$	V	0.5		2.65	
Output voltage range @ $I_{PM}$	$U_{out} - U_{ref}$	V	-2		2	
Output voltage @ $I_P = 0\text{ A}$	$U_{out}$	V		$U_{ref} + U_{OE}$		
Electrical offset voltage	$U_{OE}$	mV	-10		10	
Temperature coefficient of $U_{ref}$	$TCU_{ref}$	ppm/K			±160	-20 °C ... 85 °C Internal reference
					±190	-40 °C ... 105 °C Internal reference
Temperature coefficient of $U_{OE}$ referred to primary	$TCU_{OE}$	mV/K			±0.075	
Nominal sensitivity	$S_N$	mV/A		32		800 mV/ $I_{PN}$ @ $U_C = 5\text{ V}$
Sensitivity error	$\varepsilon_S$	%			±0.85	Factory adjustment
Temperature coefficient of $S$	$TCS$	ppm/K			±250	
Linearity error 0 ... $I_{PN}$	$\varepsilon_L$	% of $I_{PN}$			±0.5	@ $U_C = 5\text{ V}$
Linearity error 0 ... $I_{PM}$	$\varepsilon_L$	% of $I_{PM}$			±0.8	@ $U_C = 5\text{ V}$
Sensitivity error with respect to $U_C \pm 10\%$	$\varepsilon_S$	%/%			±0.05	Sensitivity error per $U_C$ drift
Magnetic offset voltage @ $I_P = 0$ after $2.5 \times I_{PN}$	$U_{OM}$	mV			±7	
Delay time @ 10 % of the final output value $I_{PN}$ step	$t_{D10}$	µs			2	$di/dt = I_{PN}/\mu s$
Delay time @ 90 % of the final output value $I_{PN}$ step	$t_{D90}$	µs			3.5	$di/dt = I_{PN}/\mu s$
Frequency bandwidth (-3 dB)	$BW$	kHz		250		
Noise voltage spectral density (DC ... 100 kHz)	$u_{no}$	µV/Hz			10.5	
RMS noise voltage (DC ... 20 MHz)	$U_{no}$	mVpp		30		
Overcurrent detection		A	$2.6 \times I_{PN}$	$2.9 \times I_{PN}$	$3.2 \times I_{PN}$	peak value
Sum of sensitivity and linearity error @ $I_{PN}$	$\varepsilon_{SL}$	% of $I_{PN}$			±1.35	$= \varepsilon_S + \varepsilon_L$
Sum of sensitivity and linearity error @ $I_{PN}$ @ $T_A = +85\text{ °C}$	$\varepsilon_{SL85}$	% of $I_{PN}$			±3.42	See formula note <sup>1)</sup>
Sum of sensitivity and linearity error @ $I_{PN}$ @ $T_A = +105\text{ °C}$	$\varepsilon_{SL105}$	% of $I_{PN}$			±4.1	See formula note <sup>1)</sup>

**Note:** <sup>1)</sup> Error @  $I_P$  and  $T_A = \pm [\varepsilon_{SL} + (TCS/10000) \cdot (T_A - 25) + TCU_{OE} \cdot 100 \cdot (T_A - 25) / (S_N \cdot I_P)]$ .

## Definition of typical, minimum and maximum values

Minimum and maximum values for specified limiting and safety conditions have to be understood as such as well as values shown in “typical” graphs.

On the other hand, measured values are part of a statistical distribution that can be specified by an interval with upper and lower limits and a probability for measured values to lie within this interval.

Unless otherwise stated (e.g. “100 % tested”), the LEM definition for such intervals designated with “min” and “max” is that the probability for values of samples to lie in this interval is 99.73 %.

For a normal (Gaussian) distribution, this corresponds to an interval between  $-3\sigma$  and  $+3\sigma$ . If “typical” values are not obviously mean or average values, those values are defined to delimit intervals with a probability of 68.27 %, corresponding to an interval between  $-\sigma$  and  $+\sigma$  for a normal distribution.

Typical, maximal and minimal values are determined during the initial characterization of a product.



## Maximum continuous DC primary current

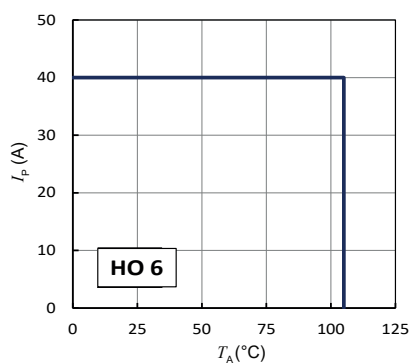


Figure 1:  $I_p$  vs  $T_A$  for HO series

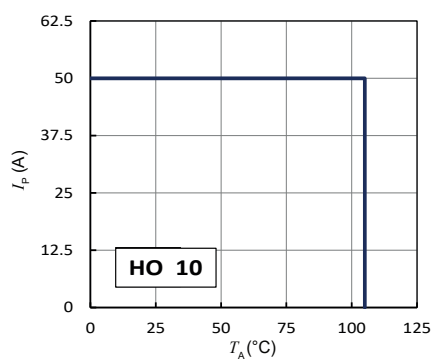


Figure 2:  $I_p$  vs  $T_A$  for HO series

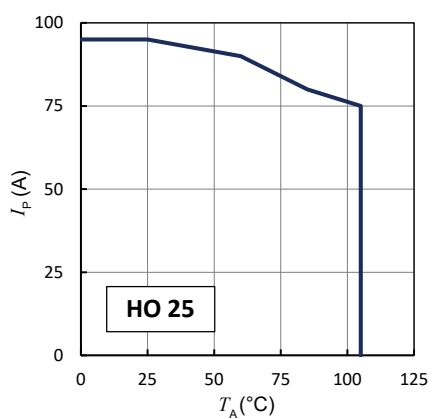
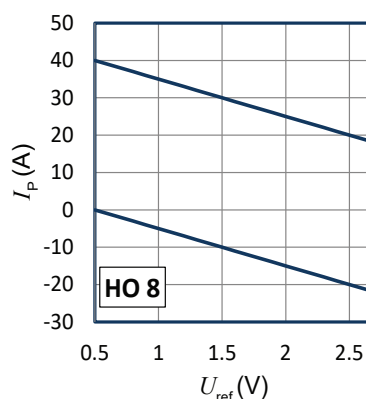


Figure 3:  $I_p$  vs  $T_A$  for HO series

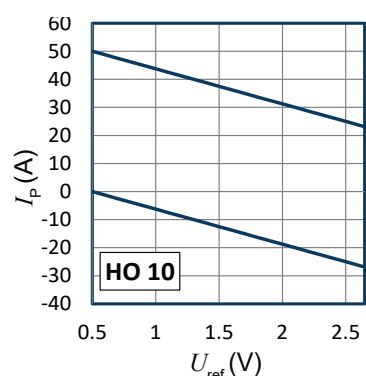
Important notice: whatever the usage and/or application, the primary conductor temperature shall not go above the maximum rating of 125 °C as stated in [page 3](#) of this datasheet.

## Measuring range with external reference voltage



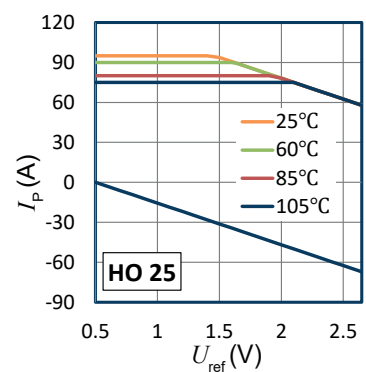
Upper limit:  $I_p = -10 \times U_{ref} + 45$  ( $U_{ref} = 0.5 \dots 2.65$  V)

Lower limit:  $I_p = -10 \times U_{ref} + 5$  ( $U_{ref} = 0.5 \dots 2.65$  V)



Upper limit:  $I_p = -12.5 \times U_{ref} + 56.25$  ( $U_{ref} = 0.5 \dots 2.65$  V)

Lower limit:  $I_p = -12.5 \times U_{ref} + 6.25$  ( $U_{ref} = 0.5 \dots 2.65$  V)



Upper limit:

$T_A = 105^\circ\text{C}$   $I_p = 75$  ( $U_{ref} = 0.5 \dots 2.1$  V)  
 $I_p = -31.25 \times U_{ref} + 140.63$  ( $U_{ref} = 2.1 \dots 2.65$  V)

$T_A = 85^\circ\text{C}$   $I_p = 80$  ( $U_{ref} = 0.5 \dots 1.94$  V)  
 $I_p = -31.25 \times U_{ref} + 140.63$  ( $U_{ref} = 1.94 \dots 2.65$  V)

$T_A = 60^\circ\text{C}$   $I_p = 90$  ( $U_{ref} = 0.5 \dots 1.62$  V)  
 $I_p = -31.25 \times U_{ref} + 140.63$  ( $U_{ref} = 1.62 \dots 2.65$  V)

$T_A = 25^\circ\text{C}$   $I_p = 95$  ( $U_{ref} = 0.5 \dots 1.46$  V)  
 $I_p = -31.25 \times U_{ref} + 140.63$  ( $U_{ref} = 1.46 \dots 2.65$  V)

Lower limit:  $I_p = -31.25 \times U_{ref} + 15.63$  ( $U_{ref} = 0.5 \dots 2.65$  V)

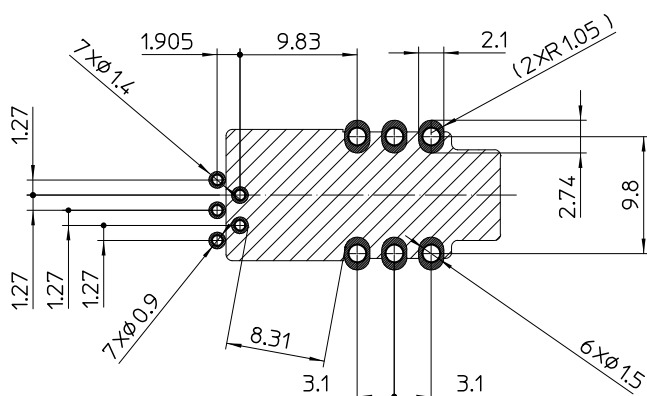
Example with  $U_{ref} = 0.5$  V:

- The 6 A version has a measuring range from 0 A to 40 A
- The 10 A version has a measuring range from 0 A to 50 A
- The 25 A version has a measuring range from 0 A to 75 A at  $T_A = 105^\circ\text{C}$

Example with  $U_{ref} = 1.5$  V:

- The 6 A version has a measuring range from -10 A to + 30 A
- The 10 A version has a measuring range from -18.7 A to + 56.3 A
- The 25 A version has a measuring range from -31.2 A to + 80 A at  $T_A = 85^\circ\text{C}$

## PCB Footprint



## Assembly on PCB

- Recommended PCB hole diameter  
1.5 mm for retention pin  
0.9 mm for secondary pin
- Maximum PCB thickness  
2.4 mm
- Wave soldering profile  
maximum 260 °C, 10 s
- No clean process only

## Terms and definitions

### Ampere-turns and amperes

The transducer is sensitive to the primary current linkage  $\Theta_p$  (also called ampere-turns).

$$\Theta_p = N_p \cdot I_p$$

Where  $N_p$  is the number of primary turn (depending on the connection of the primary jumpers).

Caution: As most applications will use the transducer with only one single primary turn ( $N_p = 1$ ), much of this datasheet is written in terms of primary current instead of current linkages. However, the ampere-turns (A) unit is used to emphasis that current linkages are intended and applicable.

### Simplified transducer model

The static model of the transducer with voltage output at temperature  $T_A$  is:

$$U_{out} = S \cdot \Theta_p (1 + \varepsilon)$$

In which (referred to primary):

$$\varepsilon \cdot \Theta_p = U_{OE} + U_{OT} + \varepsilon_s \cdot \Theta_p + \varepsilon_{sT} \cdot \Theta_p + \varepsilon_L(\Theta_{pmax}) \cdot \Theta_{pmax} + I_{OM}$$

$\Theta_p = N_p \cdot I_p$ : primary current linkage (A)

$\Theta_{pmax}$ : maximum primary current linkage applied to the transducer

$U_{out}$ : output voltage (V)

$S$ : sensitivity of the transducer

$T_A$ : ambient operating temperature (°C)

$U_{OE}$ : electrical offset voltage (V)

$I_{OM}$ : magnetic offset current (A)

$U_{OT}$ : temperature variation of  $U_{OE}$  (V)

$\varepsilon_s$ : sensitivity error at 25 °C

$\varepsilon_{sT}$ : temperature variation of sensitivity error

$\varepsilon_L(\Theta_{pmax})$ : linearity error for  $\Theta_{pmax}$

This model is valid for primary ampere-turns  $\Theta_p$  between  $-\Theta_{pmax}$  and  $+\Theta_{pmax}$  only.

This is the absolute maximum error. As all errors are independent, a more realistic way to calculate the error would be to use the following formula:

$$\varepsilon = \sqrt{\sum_{i=1}^N \varepsilon_i^2}$$

### Total error referred to primary

The total error  $\varepsilon_{tot}$  is the error at  $\pm I_{PN}$ , relative to the rated value  $I_{PN}$ .

It includes all errors mentioned above:

- the electrical offset  $U_{OE}$
- the magnetic offset  $U_{OM}$
- the sensitivity error  $\varepsilon_s$
- the linearity error  $\varepsilon_L$  (to  $I_{PN}$ ).

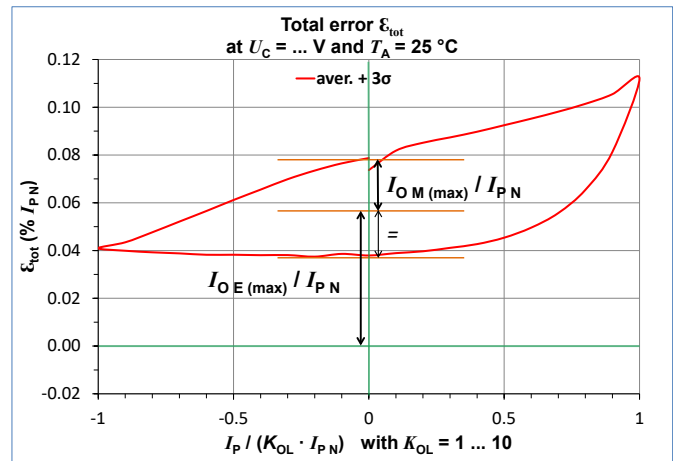


Figure 4: Total error  $\varepsilon_{tot}$

### Electrical offset referred to primary

Using the current cycle shown in figure 4, the electrical offset voltage  $U_{OE}$  is the residual output referred to primary when the input current is zero.

$$U_{OE} = \frac{U_{out(3)} + U_{out(5)}}{2}$$

The temperature variation  $U_{OT}$  of the electrical offset current  $I_{OE}$  is the variation of the electrical offset from 25 °C to the considered temperature.

$$I_{OT}(T) = I_{OE}(T) - I_{OE}(25\text{ °C})$$

### Magnetic offset referred to primary

The magnetic offset voltage  $U_{OM}$  is the consequence of a current on the primary side ("memory effect" of the transducer's ferro-magnetic parts). It is measured using the following primary current cycle.  $U_{OM}$  depends on the current value  $I_P \geq I_{PN}$ .  $K_{OL}$ : Overload factor

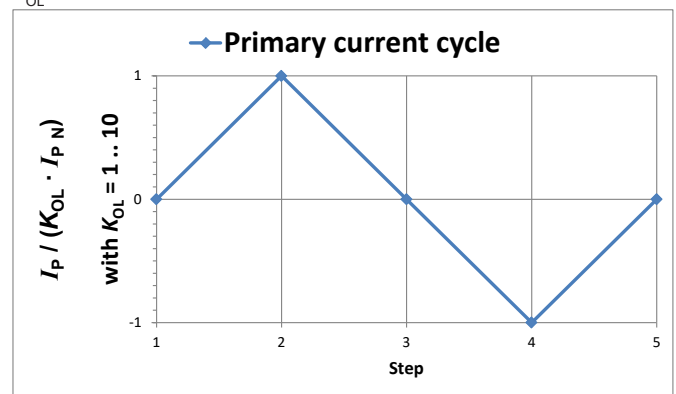


Figure 5: Current cycle used to measure magnetic and electrical offset (transducer supplied)

$$U_{OM} = \frac{U_{out(3)} - U_{out(5)}}{2}$$

## Performance parameters definition

### Sensitivity and linearity

To measure sensitivity and linearity, the primary current (DC) is cycled from 0 to  $I_P$ , then to  $-I_P$  and back to 0 (equally spaced  $I_P/10$  steps). The sensitivity  $S$  is defined as the slope of the linear regression line for a cycle between  $\pm I_{PN}$ .

The linearity error  $\varepsilon_L$  is the maximum positive or negative difference between the measured points and the linear regression line, expressed in % of  $I_{PN}$ .

### Delay times

The delay time  $t_{D10}$  @ 10 % and the delay time  $t_{D90}$  @ 90 % with respect to the primary are shown in the next figure.

Both slightly depend on the primary current  $di/dt$ .

They are measured at nominal current.

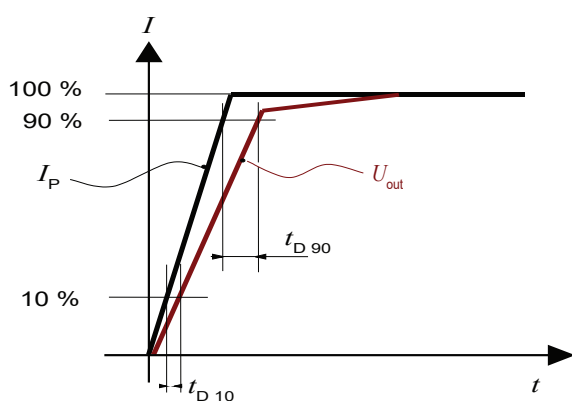


Figure 6:  $t_{D10}$  (delay time @ 10 %) and  $t_{D90}$  (delay time @ 90 %)

**Dimensions HO 6-P, 10-P, 25-P** (in mm, general linear tolerance  $\pm 0.5$  mm)



- There are 6 retention pins which have to be used only for retention as well as into the section called "Assembly on PCB"
- The primary conductor to be measured should go through the aperture 8 × 8 mm.

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